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## ISSN: 2349-5162 | ESTD Year: 2014 | Monthly Issue



## JOURNAL OF EMERGING TECHNOLOGIES AND INNOVATIVE RESEARCH (JETIR)

An International Scholarly Open Access, Peer-reviewed, Refereed Journal

**Ref No : JETIR / Vol 7 / Issue 10 / 110** 

**Confirmation Letter** 

To,

Dr.Rajesh Ranjan

Published in : Volume 7 | Issue 10 | 2020-10-13



Subject: Publication of paper at International Journal of Emerging Technologies and Innovative Research.

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: Volume 7 | Issue 10 | 2020-10-13 Published in

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: Dr.Rajesh Ranjan

Thank you very much for publishing your article in JETIR. We would appreciate if you continue your support and keep sharing your knowledge by writing for our journal JETIR.















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